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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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SERIAL NO. ATTY DOCKET NO. Form PTO 1449 (Modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 09/904,889 210817US2 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Hidenobu SAKAMOTO, et al. **FILING DATE GROUP** July 16, 2001 1614 **U.S. PATENT DOCUMENTS EXAMINER DOCUMENT SUB FILING DATE** DATE NAME CLASS INITIAL NUMBER CLASS IF APPROPRIATE AA AB AC AD ΑE AF AG AH ΑI AJ ΑK AL AM AN **FOREIGN PATENT DOCUMENTS DOCUMENT TRANSLATION** DATE COUNTRY NUMBER NO AO 9-223600 08/26/1997 JAPAN (with English Abstract) X AP 3-43904 07/04/1991 JAPAN (with English Abstract) X AQ AR AS AT ΑU ΑV OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) AW AX AY Additional References sheet(s) attached Examiner ayel Date Considered 3/30/05 *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.